

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10553411	BOSSERT ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	HUY HO	2617

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
455	562.1,561,550.1	3/24/08	Ichieh Cheng
370	330	10/7/2008	HH

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Text search attached	3/24/08	Ichieh Cheng
EAST Search and Inventor search	10/7/2008	HH
Search Update	5/23/2009	HH
Search Update	12/2/2009	HH
Search Update	6/3/2010	HH
Search Update	1/15/2011	HH
Claimed Subject matter and allow subject matter were consulted with Primary Examiners Huy Phan, Michael Thier and Steven H. Nguyen.	1/13/2011	HH
Search Update	7/22/2011	HH

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
370	334	7/22/2011	HH
455	562.1	7/22/2011	HH

/HUY C HO/  
Examiner.Art Unit 2617